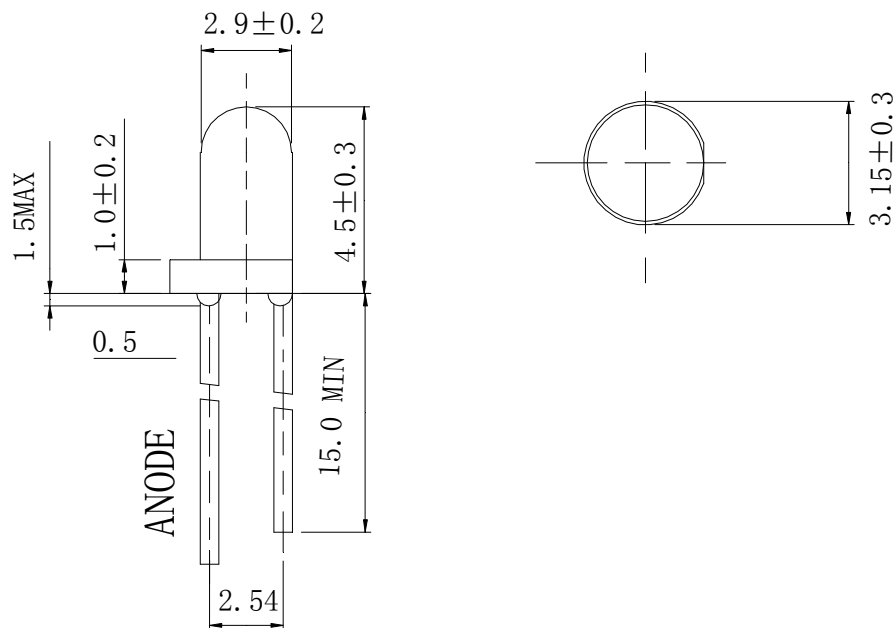


Features

- 3mm DIA LED Lamp
- Low Power Consumption
- High Efficiency
- Various Colors and Viewing Angle
- Long Solid State Reliability
- Package: 1000pcs/Packing

Applications

- Indicator

Package Dimensions**Notes:**

1. All dimensions are in millimeters (inches).
2. Tolerance is $\pm 0.25\text{mm}$ (.01") unless otherwise noted.
3. Protruded Resin under flange is 1.0mm(0.04") max.
4. Specifications are subject to change without notice.



Selection Guide

Part No	Lens Type	Dice	Emitted Color
FDL-3451W-RET30HCSTN	Water Clear	InGaN	White

Electrical / Optical Characteristics At Ta=25°C

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Condition
Iv	Luminous Intensity	2800	7200	11200	mcd	IF=30mA
2θ1/2	Viewing Angle		40		deg	
x	Chromaticity Coordinates		0.26			IF=30mA
y			0.27			
VF	Forward Voltage	2.8	3.5	3.8	V	IF=30mA

Note:

1. θ1/2 is the angle from optical centerline where the luminous intensity is 1/2 optical centerline value
2. The chromaticity coordinates(x,y) is derived form 1931 CIE chromaticity diagram.
3. The chromaticity coordinates(x,y) guarantee should be added±0.02 tolerance.

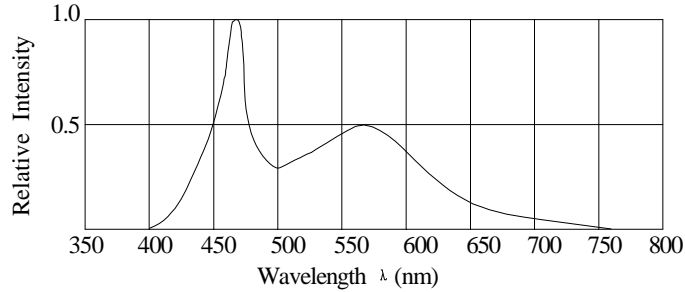
Absolute Maximum Ratings At Ta=25°C

Parameter	White	Unit
Power Dissipation	120	mW
Peak Forward Current	100	mA
Continuous Forward Current	40	mA
Dreading Linear From25°C	0.25	mA/°C
Reverse Voltage	5	V
Electrostatic Discharge Threshold(HBM)	4000	V
Operating Temperature Range	-20°C to + 80°C	
Storage Temperature Range	-55°C to + 85°C	
Soldering Condition	260°C For 5 Seconds	

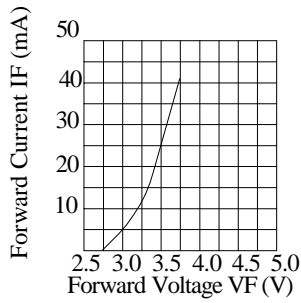
Note:

1. 1/10DutyCycle,0.1msPulseWidth

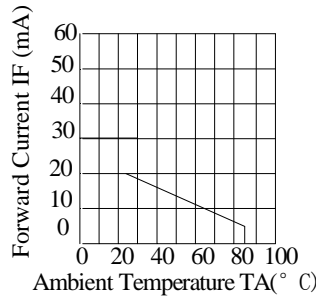
Electrical Optical Characteristics Curves At Ta=25°C



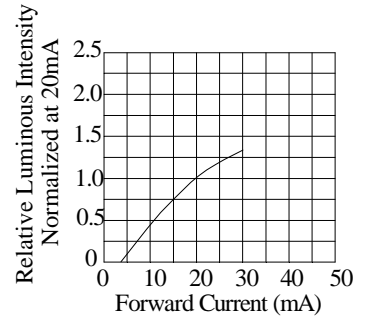
Relative Intensity VS. Wavelength



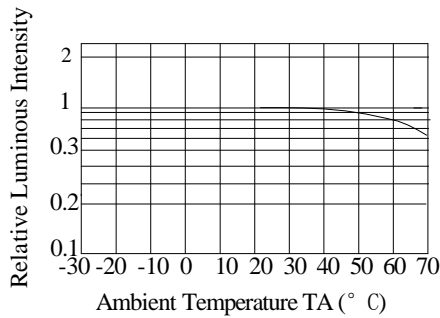
Forward Current vs. Forward Voltage



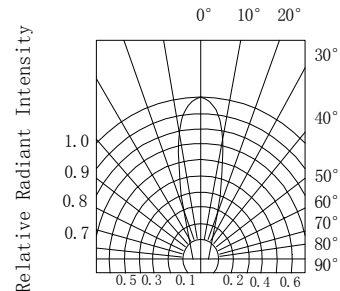
Derating Curve



Relative Luminous Intensity vs. Forward Current



Luminous Intensity vs. Ambient Temperature



Radiation Diagram

Notes:

1. The LEDs should be used within a year.
2. The LEDs should be kept in 5~30°C and 60% RH for less.
3. The LEDs should be used within 24 hours, or else should be kept a 5~30°C and 30% RH or less. And LEDs should be used within 7 days after opening the package.

Bin Range Of Luminous Intensity (+/-20%)

Symbol	Bin Code	Min.	Max.	Unit	Condition
Iv	N10	2800	3600	mcd	IF=30mA
	N20	3600	4500		
	P10	4500	5700		
	P20	5700	7200		
	Q10	7200	9000		
	Q20	9000	11200		

Bin Range Of Forward Voltage (+/-0.15)

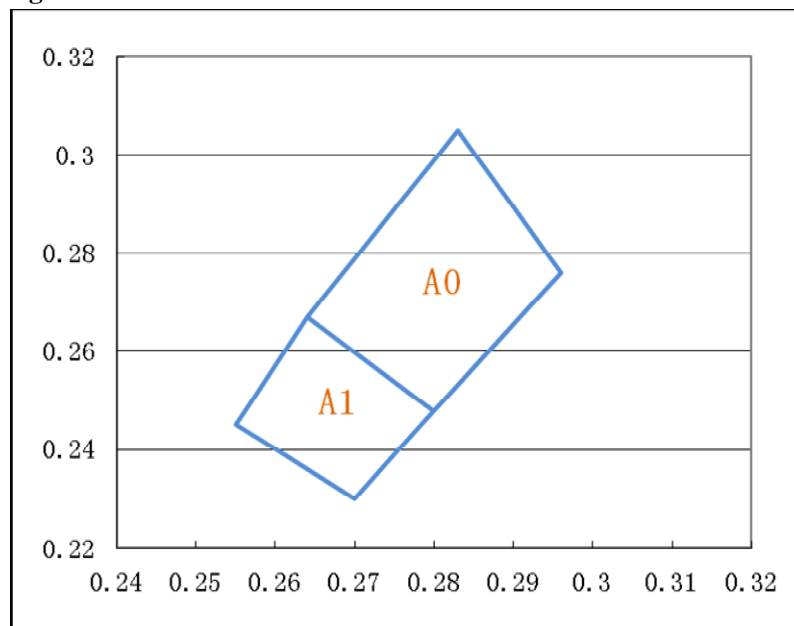
Symbol	Bin Code	Min.	Max.	Unit	Condition
VF	VA	2.8	3.0	V	IF=30mA
	V1	3.0	3.2		
	V3	3.2	3.4		
	V5	3.4	3.6		
	V7	3.6	3.8		

Chromaticity Coordinates Specifications for Bin Grading (+/-0.02)

IF=30mA

A1	0.255	0.245	A0	0.264	0.267
	0.264	0.267		0.283	0.305
	0.28	0.248		0.296	0.276
	0.27	0.23		0.28	0.248

CIE Chromaticity Diagram





Reliability Test Items Conditions

Classification	Test Item	Test Conditions	Test hours	Result
Endurance Test	Operation Life	Connect with a power $I_F=30mA$ T_a =Under room temperature	1000Hrs	0/20
	High Temperature High Humidity	$T_a=+65^{\circ}C \pm 5^{\circ}C$ RH=90%-95%	240Hrs	0/20
	High Temperature Storage	High $T_a=+85^{\circ}C \pm 5^{\circ}C$	1000Hrs	0/20
	Low Temperature Storage	Low $T_a=-35^{\circ}C \pm 5^{\circ}C$ Test time=1000hrs	1000Hrs	0/20
Environmental Test	Temperature Cycling	$-45^{\circ}C \sim +105^{\circ}C$ 15min 5min 15min	300 Cycles	0/20
	Thermal Shock	$-35^{\circ}C \sim \pm 5^{\circ}C \sim +85^{\circ}C \sim \pm 5^{\circ}C$ 5min 10sec 5min	300 Cycles	0/20
	Solder Resistance	Preheating: $120^{\circ}C - 150^{\circ}C$, within 2 minutes. Operation heating : $260^{\circ}C$ (Max.), within 5 seconds (Max.)	5Cycles	0/20

Judgment criteria of failure for the reliability

Measuring items	Symbol	Measuring conditions	Judgment criteria for failure
Forward voltage	$V_F(V)$	$I_F=30mA$	Over $U \times 1.2$
Reverse current	$I_R(\mu A)$	$V_R=5V$	Over $U \times 2$
Luminous intensity	$I_v(mcd)$	$I_F=30mA$	Below $S \times 0.5$

Note: 1.U means the upper limit of specified characteristics. S means initial value.
2.Measurment shall be taken between 2 hours after the test pieces have been returned to normal ambient conditions after completion of each test.